

### SLOVENSKI STANDARD SIST EN 123600:2001

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## Sectional Specification: Flex-rigid multilayer printed boards with through connections

Sectional Specification: Flex-rigid multilayer printed boards with through connections

Rahmenspezifikation: Starr-flexible Mehrlagen-Leiterplatten mit Durchverbindungen

Spécification intermédiaire: Cartes imprimées multicouches flexorigides avec connexions transversales (standards.iteh.ai)

Ta slovenski standard je istoveten z: EN 123600:1996

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## EUROPEAN STANDARD NORME EUROPÉENNE EUROPÄISCHE NORM

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Descriptors: Multilayer printed boards, with through connections, capability test, quality conformance inspection, test patterns

**English version** 

## Sectional Specification: Flex-rigid multilayer printed boards with through connections

Spécification intermédiaire: Cartes imprimées multicouches flexorigides avec connexions transversales

Rahmenspezifikation: Biegesteife Mehrlagen-Leiterplatten mit Durchverbindungen

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#### SIST EN 123600:2001

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European Committee for Electrotechnical Standardization Comité Européen de Normalisation Electrotechnique Europäisches Komitee für Elektrotechnische Normung

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#### Foreword

This European Standard was prepared by CLC/TC CECC/SC 52, Printed boards (former WG 23).

It is based, wherever possible, on the Publications of the International Electrotechnical Commission, and in particular on IEC 326-11, Printed boards, Part 11: Specification for flex-rigid multilayer printed boards with through connections.

The text of the draft based on document CECC(Secretariat)2823 was submitted to the formal vote; together with the voting report, circulated as document CECC(Secretariat)3022, it was approved as EN 123600 on 1992-02-14.

The following dates were fixed:

 latest date by which the EN has to be implemented at national level by publication of an identical national standard or by endorsement

(dop) 1997-07-01

latest date by which the national standards conflicting with the EN have to be withdrawn

(dow) 2003-05-01

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#### 1 Introduction

IEC 326-11 is the IEC Standard for flex-rigid multilayer printed boards with through connections. The following document comprises this IEC Standard and in accordance with the Generic Specification EN 123000, the information additionally necessary for printed boards intended to be handled within the CENELEC system for electronic components of assessed quality.

#### 1.1 Scope and object

This document is a Sectional Specification (SS) relating to flex-rigid multilayer printed boards with through connections irrespective of their method of manufacture, when they are ready for the mounting of the components. It defines the characteristics to be assessed and the test methods to be used for capability approval testing and for quality conformance inspection (lot-by-lot and periodic inspection).

#### 1.2 Related documents

IEC 68	Basic environmental testing procedures
IEC 97	Grid system for printed circuits
IEC 194	Terms and definitions for printed circuits
IEC 249	Metal-clad base materials for printed circuits
IEC 326-1	Printed boards, instructions for the specification writer
IEC 326-2	Test methods for printed boards
IEC 326-3	Recommendations for the design and the use of printed boards
IEC 326-11	Specification for the design and use of flex-rigid multilayer printed boards with through-connections

#### 2 General iTeh STANDARD PREVIEW

This Sectional Specification (SS) applies to flex-rigid printed boards with through-connections and is intended as a basis for the preparation of a

- Capability Detail Specification (CapDS) applying to specific materials e.g., according to IEC 249-2, and to be used for Capability Approval Procedures. It may be necessary to have a CapDS for each type of material. A CapDS may be prepared by an international or national body or by a manufacturer (see also CECC 00 111 / IV).
- <u>Customer Detail Specification (CDS)</u> for the custom built printed boards, according to clause 5 of EN 123000. The CDS will normally be written by the customer and allocated a number within his own system. Further details are also given in EN 123000 and CECC 00 114 / III.

<u>Table I</u> contains the basic characteristics that will normally be important for flex-rigid multilayer printed boards with through-connections and makes reference to the appropriate tests to verify these characteristics.

<u>Table II</u> contains the additional characteristics that may be important for certain flex-rigid multilayer printed boards with through connections and / or certain applications and makes reference to the appropriate tests to verify these characteristics. Where necessary, the relevant specification may quote characteristics and tests from this Table II.

Where additional details for a test have to be specified in the relevant specification, this shall be indicated by '\*' in the relevant column. These details shall then be specified in accordance with CECC 00 010 (IEC 326-2).

<u>Table III</u> contains the capability test programme. A specified composite test pattern (CTP) is used as a capability qualifying component.

Table IV contains the information for the quality conformance inspection.

The tables are not intended to prescribe a test sequence. The tests may be carried out in any sequence, unless otherwise specified.

#### 3 Test specimen

A test specimen, which may be specifically designed for this purpose (composite test pattern), or taken from production (production board), which is used for verifying capability in accordance with the relevant Generic Specification. A suitable composite test pattern is shown in Figures 3a, 3b, 3c, 3e, 3f, 3d, 3g, 3h, 4a, and 4b.

#### 3.1 Capability Approval

#### 3.1.1 Basic capability

The test shall be carried out on the composite test pattern given in clause 8.

#### 3.1.2 Additional capability

Clause 3.5.3 of EN 123000 shall apply. For multiple arrangements; see also clause 8.

#### 3.1.3 Maintenance of Capability Approval

Clause 3.8 of EN 123000 shall apply.

#### 3.2 Quality conformance inspection

Unless otherwise specified, production boards and/or specially designed test patterns may be used for carrying out tests for the lot-by-lot and the periodic inspection.

Where specifically designed test patterns shall be used they may be included in the panel. They may be based on the appropriate pattern of the composite test pattern; see clause 8. Consultation between manufacturer and customer will usually be necessary.

### 4 Relevant specification SIST EN 123600:2001 https://standards.iteh.ai/catalog/standards/sist/8d9ebd26-7ce6-47e7-b6fb-

The term relevant specification means a product specification for an actual printed board., i.e. a CDS as well as a CapDS applied to a specific material and technique, as applicable.

The relevant specification shall contain all information necessary to define the printed board clearly and completely. The recommendations given in IEC 326-3 shall preferably be followed.

Care should be taken to avoid unnecessary prescription. Permissible deviations should be stated where necessary, nominal values without tolerances or simple maxima or minima shall be given where sufficient. Where tolerances are necessary for certain areas or parts of the printed board only, they shall be applied and restricted to those areas or parts.

If there are several possibilities of presentation of tolerance classes etc., the selections given in IEC 326-3 shall preferably be applied.

In cases of discrepancy between the CDS and other pertinent specifications (e.g. BS, GS, or SS), the CDS shall prevail.

#### 5 Characteristics of the printed board

Basic characteristics, see table I Additional Characteristics, see table II

Table I: Basic characteristics (mandatory assessments)

Characteristics	Test No. IEC 326-2	Addi- tional Tests	Specimen of Composite Test Pattern	Requirements	Remarks
General Examination Visual Examination			٠		
Conformity and Identification	1	•	Complete printed board or composite test pattern	Pattern, marking, identification, material and finishes shall comply with the relevant specification. There shall be no apparent defects.	
Appearance and Workmanship	1a iTeh	(stai	Complete printed board or composite test pattern SIST EN 123600:2 talog/standards/sist/	The boards shall appear to have been processed in a careful and workmanlike manner, in accordance with good current practice.	
Plated-through holes	upo//surkur	bdbd2	Complete - 123 printed board or composite test pattern	Plated-through holes shall be clean and free from inclusions of any sort that could affect component insertion and solderability,	
				Total area of the voids shall not exceed 10% of the total wall area. The largest dimension shall not exceed 25% of the hole circumference in the horizontal plane and 25% of the thickness	
				of the board in the vertical plane.  Plated-through holes shall have no plating voids at the interface of the hole wall and the conductive pattern or internal layer ring.	-

<sup>\*</sup> see clause 2

Characteristics	Test No. IEC 326-2	Addi- tional Tests	Specimen of Composite Test Pattern	Requirements	Remarks
•	·			The interface shall be considered to extend into the hole below the surface of the board a distance of 1,5 times the total copper thickness on the surface or to be two times the inner layer thickness at the level of contact ring.	
	1c			Resin smear at the edge of the clad copper and the continuous plated copper is permitted provided the smear does not interrupt electrical continuity.	a.
	iTeh	STAI (star	NDARD	There shall be no circumferential cracks of the copper, or circumferential separation of the copper from the wall	
ht	tps://standard	:	alog/standards/sist/8 :639b4/sist-en-1230	of the plated-through hole of the blaten	1-00
	-		· · · · · · · · · · · · · · · · · · ·	voids shall not exceed 5% of the total number of plated -through holes	
Board Edges			Complete printed board or composite test pattern	The edges of the board and internal cut- outs shall be clean cut without tears or nicks	
Eyelets			Complete printed board or composite test pattern	Eyelets shall be firmly secured. Plated eyelets shall not have exposed bare metal. Eyelets shall not have cracked flanges. There shall be no damage to conductors or substrate around the eyelet.	

Characteristics	Test No. IEC 326-2	Addi- tional Tests		Requirements	Remarks
Bonding Conductor to Substrate	1a		Complete printed board or composite test pattern	There shall be no separation of the conductors from the substrate by apparent blisters or wrinkles other than those permitted in the material specification.	•
Bonding Coverlayer to substrate and pattern	1		Complete printed board	The bonding shall appear to be complete and uniform, Minor delaminations are permitted in the following positions:	
	1a			a) At random locations away from the conductors. Such delaminations shall have an area not exceeding 0.5 mm²	
		(star	SIST EN 123600:2	from the edges, and each shall be more than 0,5 mm from the edges.	
	https://standari		talog/standards/sist/ c639b4/sist-en-123	600 edges. Such delaminations shall not infringe upon the	
				design spacing between the conductors by more than 20% of the design width by visual estimation.	
			-	(see figure 5)  There shall be a minimum continuous bonding width of 0,5 mm between	·
				adjacent conductors. There shall be no delamination with conductor spacings less than 0,5 mm.	
onductor defects	1b		Complete printed board or composite est pattern	There shall be no cracks or breaks. Imperfections such as voids or edge defects are permissible, provided that the	Where necessary, this shall be verified by dimensional examination using test 2a.

Characteristics	Test No. IEC 326-2	Addi- tional Tests	Specimen of Composite Test Pattern	Requirements	Remarks
				conductor width or leakage path between conductors is not reduced by more than that specified in the relevant specification, e.g. 20% or 35%. (see figure 1)	
Particles between conductors	1b or 1c		Complete printed board or composite test pattern	Residual metallic particles are permissible provided that the leakage path is not reduced by more than 20% or to less than the distance required for circuit voltage.	Where necessary, this shall be verified by dimensional examination using test 2a.
Dimensional Examination					
Board Dimensions	iTeh 2	STA! (star	or composite test pattem <sub>0:20</sub>	Dimensions and tolerances shall comply with the relevant specification.	·
· h	tps://standard		alog/standards/sist/8 c639b4/sist-en-1236	The nominal board half thickness shall comply with the relevant specification.	
Board Thickness in the zone of edge board contacts	2		κ	The total board thickness shall comply with the relevant specification.	Total board thickness and tolerances shall be specified in accordance with IEC 321
Holes	2		Complete printed board or composite test pattern	Nominal diameters and tolerances of mounting holes and of component holes shall comply with the relevant specification.	A recommended range of holes and tolerances is given in IEC 326-3.
				The nominal diameter of plated-through holes used for through connections only shall comply with the relevant specifications.	Accurate measurement is not necessary since deviations are not important.
				•	

Characteristics	No. IEC 326-2	Addi- tional Tests	Specimen of Composite Test Pattern	Requirements	Remarks
Access holes	2		Complete printed board or composite test pattern		Recommended min. effective land at any point around the hole: Plain hole: 0,15 mm  Plated-through hole; 0,10 mm
Slots, notches	2		Complete printed board or composite test pattern	The dimensions shall comply with the relevant specification.	·
Conductor width	iTeh S	<u>SI</u> iteh.ai/cata	Complete printed board or composite test pattern STEN 123600:20 log/standards/sist/8639b4/sist-en-1236	Imperfections such as voids or edge defects	If no tolerances are stated, the coarse deviation given in IEC 326-3 shall apply.
				are permissible, provided the conductor width is not reduced by more than specified in the relevant specification, e.g. 20% or 35%. The length L of a defect shall not be greater than the conductor width S or 5 mm, whichever is the smaller (see figure 1)	
Spacing between conductors	2	, c	or composite est pattern	The spacing between conductors shall comply with any specific dimensions given in the relevant specification.	
Misalignment of hole and land	1a 2a	p	printed board or composite est pattern	There shall be no interruption of the land. There shall be no breakout at the junction of the land and the conductor.	

Characteristics	Test No. IEC 326-2	Addi- tional Tests	Specimen of Composite Test Pattern	Requirements	Remarks
Positional tolerance of hole centres			Complete printed board or composite test pattern	The hole centres shall be within any deviation specified in the relevant specification.	
Bonding flexible parts to rigid parts	iTeh	STAN	Complete printed board or composite test pattern	The bonding between the flexible parts and the rigid parts shall appear complete and uniform. The following conditions are permitted at the junction between flexible and rigid parts. Resin flow onto the flexible part must not exceed 2 mm beyond the junction. A non-bonded zone may also extend onto the rigid part up to 2 mm from the junction.	
Electrical Tests		(stan	dards.ite	h.ai)	
Resistance  Change in resistance of plated-through holes, thermal cycling  Eyelets	ps://standard 3c of IEC 326-2a		ST EN 123600:200 log/standards/sist/80 639b4/sig-en-1236	the relevant -specification shall be met.	Not applicable to polyester materials.
Short circuit	4a		Complete printed board or composite test pattern	Under consideration.	. ' :
Insulation Resistance	6	*		The insulation	Insulation
Preconditioning	18a	*		resistance shall comply with the relevant specification.	resistance shall be measured before and after
Measurement at standard atmospheric conditions	6	•			environmental conditioning and at elevated temperature

<sup>\*</sup> see clause 2

Characteristics	Test No. IEC 326-2	Addi- tional Tests	Specimen of Composite Test Pattern	Requirements	Remarks
Conditioning IEC 68-2-3 Test Ca damp heat steady state, or IEC 68-2-38; Test		•			Applicable conditioning to be specified in the relevant specification.
Z/AD, composite temperature / humidity cyclic test				·	
Measurement at elevated temperature	6	•			Not applicable to polyester materials.
Surface Layers Internal Layers Between layers	6a 6b 6c		E or J E or J M		
Mechanical Tests					
Peel Strength  Conductor to base material	iTeh	STAI (star	NDARD Idards.it		· ye
Measurement at standard atmospheric conditions	tps://standard	S.iteh.ai/cat bdbd21	IST EN 123600:20 alog/standards/sist/ 6639b4/sist-en-123	d9ebd26-7ce6-47e7-b6fb-	
Measurement at elevated temperature	10b	* -	·		Not applicable to polyester
Pull-off strength		:	•		materials.
Pull-off strength, lands with plain holes	11a	*	C	The land shall not become detached during the soldering operation. The pull-off strength shall not be less than the value specified in the relevant specification.	A flexible specimen needs to be supported by a rigid board.
Pull-out strength					
andless plated- nrough holes	11b			The pull-out strength shall not be less than the value specified in the relevant spec.	

<sup>\*</sup> see clause 2

Characteristics	Test No. IEC 326-2	Addi- tional Tests	Specimen of Composite Test Pattern	Requirements	Remarks
Miscellaneous Tests Plating Finishes Adhesion of plating, tape method	13a		K	There shall be no evidence of plating adhering to the tape after removal from the conductor, other than resulting from overhang.	
Thickness of plating, contact areas	13f	·	K or printed board	The thickness shall comply with the relevant specification.	(
) When the use of a non-activated flux is agreed between purchaser and Vendor	://standards.ite	stand SIST eh.ai/catalog	H, A  DARD P  ards.itel  EN 123600:200 /standards/sist/8d96 0b4/sist-en-123600	imperfections shall not be concentrated on one area: 47e7-b6fb-0-2001	Not applicable to polyester materials. For polyimide materials, appropriate drying protecting the soldering may be necessary. Testing shall be carried out in the as received condition or after accelerated ageing, as agreed upon between purchaser and vendor.  Non-activated flux is specified in IEC 68-2-20, Sub-clause 6.6.1
s received condition			s v to c p w	Wetting: The specimen shall wet within 3 s. When emporary protective coating intended to preserve the vettability is used, the pecimen shall wet within 4 s.	-